

Notice of References Cited		Application/Control No.	Applicant(s)/Patent Under Reexamination SHEI ET AL.	
		Examiner Thien T. Mai	Art Unit 2876	Page 1 of 1

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*	Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
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B	US-2002/0104449	08-2002	Lee, Hung Hsiang	101/129
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FOREIGN PATENT DOCUMENTS

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